

Notice of References Cited	Application/Control No. 10/574,484		Applicant(s)/Patent Under Reexamination ZIJP ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,344,608	02-2002	Kariya et al.	136/257
*	B	US-7,396,580	07-2008	Kawashima et al.	428/212
	C	US-			
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	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N	JP 08-043840	02-1996	JP	Fukuyoshi et al.	G02F 1/1343
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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